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Wiskott, L.; Fellous, J.-M.; Kuiger, N.; von der Malsburg, C.;

Pattern Analysis and Machine Intelligence, IEEE Transactions on , Volume:

19 , Issue: 7 , July 1997

Pages:775 - 779

[\[Abstract\]](#) [\[PDF Full-Text \(160 KB\)\]](#) **IEEE JNL**
2 Face recognition by elastic bunch graph matching
Wiskott, L.; Fellous, J.-M.; Kruger, N.; von der Malsburg, C.;

Image Processing, 1997. Proceedings., International Conference on , Volume

1 , 26-29 Oct. 1997

Pages:129 - 132 vol.1

[\[Abstract\]](#) [\[PDF Full-Text \(416 KB\)\]](#) **IEEE CNF**
3 Phantom faces for face analysis
Wiskott, L.;

Image Processing, 1997. Proceedings., International Conference on , Volume

3 , 26-29 Oct. 1997

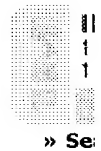
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jet and node

Search

☐ Check to search within this result set**Results Key:****JNL** = Journal or Magazine **CNF** = Conference **STD** = Standard**1 NEPTUNE regional observatory system design**

Rodgers, D.H.; Maffei, A.; Beauchamp, P.M.; Massion, G.; Chave, A.D.; McGinnis, T.M.; Gaudet, S.; Wilcock, W.S.D.; Kirkham, H.;
 OCEANS, 2001. MTS/IEEE Conference and Exhibition, Volume: 3, 5-8 Nov. 2001.
 Pages:1356 - 1365 vol.3

[\[Abstract\]](#) [\[PDF Full-Text \(801 KB\)\]](#) **IEEE CNF**
2 All-optical WDM packet networks

Monacos, S.P.; Morookian, J.M.; Davis, L.; Bergman, L.A.; Forouhar, S.; Saunder, J.R.;
 Lightwave Technology, Journal of, Volume: 14, Issue: 6, June 1996
 Pages:1356 - 1370

[\[Abstract\]](#) [\[PDF Full-Text \(1680 KB\)\]](#) **IEEE JNL**
3 Determination of the eigenfrequencies of a ferrite-filled cylindrical resonator using the finite element method

Chinn, G.C.; Epp, L.W.; Wilkins, G.M.;
 Microwave Theory and Techniques, IEEE Transactions on, Volume: 43, Issue: 5, May 1995
 Pages:1207 - 1209

[\[Abstract\]](#) [\[PDF Full-Text \(228 KB\)\]](#) **IEEE JNL**
4 Hybrid finite element-modal analysis of jet engine inlet scattering

Ross, D.C.; Volakis, J.L.; Anastassiou, H.T.;
 Antennas and Propagation, IEEE Transactions on, Volume: 43, Issue: 3, March 1995
 Pages:277 - 285

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jet and (image and graph)

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☐ Check to search within this result set**Results Key:****JNL** = Journal or Magazine **CNF** = Conference **STD** = Standard**1 Distortion invariant object recognition by matching hierarchically la graphs***Buhmann, J.; Lange, J.; von der Malsburg, C.;*

Neural Networks, 1989. IJCNN., International Joint Conference on , 18-22 Jun 1989

Pages:155 - 159 vol.1

[\[Abstract\]](#) [\[PDF Full-Text \(684 KB\)\]](#) **IEEE CNF**
2 Part decomposition and description of 3D shapes*Rom, H.; Medioni, G.;*

Pattern Recognition, 1994. Vol. 1 - Conference A: Computer Vision & Image Processing., Proceedings of the 12th IAPR International Conference on , Volu 1 , 9-13 Oct. 1994

Pages:629 - 632 vol.1

[\[Abstract\]](#) [\[PDF Full-Text \(480 KB\)\]](#) **IEEE CNF**
3 Recognition and localization of 3-D natural quadric objects based on active sensing*Lee, S.; Hahn, H.;*

Robotics and Automation, 1991. Proceedings., 1991 IEEE International Conference on , 9-11 April 1991

Pages:156 - 161 vol.1

[\[Abstract\]](#) [\[PDF Full-Text \(580 KB\)\]](#) **IEEE CNF**
4 Face recognition using discrete wavelet graph*Kun Ma; Xiaou Tang;*

Acoustics, Speech, and Signal Processing, 2003. Proceedings. (ICASSP '03). 2